

Notice of References Cited	Application/Control No. 10/814,817	Applicant(s)/Patent Under Reexamination LIPKA ET AL	
	Examiner Hoang V. Nguyen	Art Unit 2821	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0201939 A1	10-2003	Reece et al.	343/700.0MS
	B	US-			
	C	US-			
	D	US-			
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FOREIGN PATENT DOCUMENTS

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